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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.	
10/023,940	12/21/2001	Jin-goo Park	1751-297	7717	
6449	7590 10/05/2004		EXAM	EXAMINER	
ROTHWELL, FIGG, ERNST & MANBECK, P.C. 1425 K STREET, N.W.			KORNAKOV. MICHAIL		
SUITE 800	SEI, IV. W.		ART UNIT	PAPER NUMBER	
WASHINGT	ON, DC 20005		1746		
			DATE MAILED: 10/05/2004		

Please find below and/or attached an Office communication concerning this application or proceeding.

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	Application No		Applicant(s)	U
Office = 4 - 45 2	10/023,940		PARK ET AL.	
Office Action Summary	Examiner	-	Art Unit	
	Michael Korna		1746	`
The MAILING DATE of this communication Period for Reply	n appears on the cove	er sheet with the co	orrespondence ad	ldress
A SHORTENED STATUTORY PERIOD FOR R THE MAILING DATE OF THIS COMMUNICAT  - Extensions of time may be available under the provisions of 37 C after SIX (6) MONTHS from the mailing date of this communicati  - If the period for reply specified above is less than thirty (30) days  - If NO period for reply is specified above, the maximum statutory  - Failure to reply within the set or extended period for reply will, by Any reply received by the Office later than three months after the earned patent term adjustment. See 37 CFR 1.704(b).	ON. FR 1.136(a). In no event, hovon. a reply within the statutory moeriod will apply and will expire statute. cause the application.	vever, may a reply be time nimum of thirty (30) days s SIX (6) MONTHS from to to become ABANDONED	eiy filed will be considered time! he mailing date of this co	y. ommunication.
Status		* .		
1) Responsive to communication(s) filed on	23 July 2004.			
<del></del>	This action is non-fir	al.		
3) Since this application is in condition for al	owance except for fo	rmal matters, pros	secution as to the	merits is
closed in accordance with the practice un				
Disposition of Claims				
4)⊠ Claim(s) <u>1-4</u> is/are pending in the applica	ion			
4a) Of the above claim(s) <u>1 and 2</u> is/are w		eration		
5)⊠ Claim(s) <u>4</u> is/are allowed.	and an morn contour	oration.		
6)⊠ Claim(s) <u>3</u> is/are rejected.				
7) Claim(s) is/are objected to.				
8) Claim(s) <u>1-4</u> are subject to restriction and	or election requireme	ent.	4	
Application Papers				
9)☐ The specification is objected to by the Exa	miner.			
10)⊠ The drawing(s) filed on 21 December 2003		ed or b)∏ objecte	d to by the Exam	iner
Applicant may not request that any objection to				
Replacement drawing sheet(s) including the co				R 1,121(d).
11)☐ The oath or declaration is objected to by th	e Examiner. Note the	attached Office A	Action or form PT	O-152.
Priority under 35 U.S.C. § 119				
12) Acknowledgment is made of a claim for for a) All b) Some * c) None of:	eign priority under 35	U.S.C. § 119(a)-	(d) or (f).	
1.☐ Certified copies of the priority docur	nents have been rece	ived.	,	
2. Certified copies of the priority docur			n No.	
3. Copies of the certified copies of the				Stage
application from the International Bu				Ü
* See the attached detailed Office action for a	list of the certified co	pies not received		
				,
Attachment(s)	·			
Notice of References Cited (PTO-892)	4) 🗌	Interview Summary (P	PTO-413)	
Notice of Draftsperson's Patent Drawing Review (PTO-948 I) Information Disclosure Statement(s) (PTO-1449 or PTO/SE	3/08) 5)	Paper No(s)/Mail Date Notice of Informal Pate		152)
Paper No(s)/Mail Date Patent and Trademark Office		Other:		
TOL-326 (Rev. 1-04) Office	e Action Summary	Part	of Paper No./Mail Dat	e 20040930

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## **DETAILED ACTION**

- 1. The objection to the disclosure is withdrawn in view of Applicants' amendment to the specification, dated 7/23/04.
- 2. The rejections of claims 3 and 4 under U.S.C. 112, first and second paragraphs are withdrawn in view of Applicants' remarks, dated 7/23/04.
- withdrawn from consideration. Claims 3 and 4 are examined on the merits.
- 4. The text of those sections of Title 35, U.S. Code not included in this action can be found in a prior Office action.
- 5. Claim 3 is rejected under 35 U.S.C. 103(a) as being unpatentable over Fukazawa (U.S. 6,423,146) in view of Shibano (U.S. 5,383,483).

Fukazawa teaches a method for cleaning a surface of semiconductor substrate including the steps of forming a cleaning solution from ozone and ammonium hydroxide, supplying the said cleaning solution to processing chamber and processing the surface of semiconductor substrate with said cleaning solution, wherein the processing is enhanced by radiating the substrate with high frequency waves of approximately 1MHz. The concentration of ammonium hydroxide solution of Fukazawa is set to fall within the range of 0.1-5% by weight, which corresponds to the instantly claimed concentration of aqueous ammonium hydroxide. The ammonium hydroxide solution of Fukazawa is further diluted by ozone water such that the volume ration of the ozone water to the ammonium hydroxide reaches 100:1 (Abstract; col. 2, lines 5-10; col.3, lines 25-35, 42-50; col.6, lines 48-56).

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With regard to the limitation, specifying "a room temperature", since the processing temperature in Fukazawa is not specifically elucidated, one skilled in the art would have found obvious to clean the substrate at room temperature in order to simplify the processing equipment and avoid additional processing steps, utilizing the cleaning technique of Fukazawa with the reasonable expectation of success.

It is also noticed here, that the cleaning temperature is result effective, because it affects the concentration of ozone in cleaning solution, thus affecting the substrate processing time. However, discovery of optimum value of result effective variable in known process is ordinarily within the skill in the art and would have been obvious, consult *In re* Boesch and Slaney 205 USPQ 215 (CCPA 1980).

The teaching of Fukazawa remains silent about supplying the cleaning solution into a cleaning bath through a filter for removing ozone bubble. However, such degasifying filters or membranes are conventionally utilized in the art, wherein ultrasonic cleaning is involved. For example, Shibano teaches the ultrasonic cleaning of a workpiece and indicates that "the workpiece can be cleaned more effectively as a smaller amount of gas is contained in the cleaning fluid used." (col.1, lines 25-27). Shibano also states that when the ultrasonic energy is radiated into the cleaning solution by the ultrasonic radiation means, the cleaning solution is cavitated and the smoothly developed cavitation in the cleaning solution, which is well filtered is effective to clean the workpiece efficiently (col.2, lines 24-27; col.6, lines66-68). Thus, Shibano clearly motivates the skilled in the art to minimize the amount of gaseous media in the cleaning liquid during ultrasonic processing in order to enhance cleaning process. In

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order to minimize the presence of gaseous media in cleaning solution Shibano utilizes gas separating membranes (paragraph, bridging col.1 and 2). Therefore, one skilled in the art motivated by the teaching of Shibano at the time the invention was made would have found obvious to degasify the cleaning solution, utilizing appropriate membrane or filter in order to minimize the presence of gaseous bubbles in the cleaning solution of Fukazawa, thus enhancing the effectiveness of substrate ultrasonic cleaning in the method of Fukazawa with the reasonable expectation of success.

## Allowable Subject Matter

- 6. Claim 4 is allowable over the prior art of recorded.
- 7. The following is an examiner's statement of reasons for allowance: Neither the combined teaching of Fukazawa/Shibano nor the other prior art of record suggest fairly or anticipate the combination of processing steps as instantly recited, including the step of dipping a wafer surface in aqueous cleaning solution of ozone and ammonium hydroxide of recited concentration, wherein the aqueous cleaning solution is at a temperature range of 10-15°C and is circulated through a chiller.

## Response to Arguments

8. Applicant's arguments with respect to claims 3 and 4 have been considered but are most in view of the new ground(s) of rejection.

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Any inquiry concerning this communication or earlier communications from the examiner should be directed to Michael Kornakov whose telephone number is (571) 272-1303. The examiner can normally be reached on 9:00am - 5:30pm.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Michael Barr can be reached on (571) 272-1414. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

M. KORNACON

Michael Kornakov Primary Examiner Art Unit 1746

09/30/2004